

Search Notes

Application/Control No.

10/775,080

Examiner

Chun-Kuan (Mike) Lee

Applicant(s)/Patent under
Reexamination

SAKIYAMA ET AL.

Art Unit

2181

SEARCHED

Class	Subclass	Date	Examiner
710	8	4/22/2007	CHUN-KUAN Lee
710	13	4/22/2007	
710	17	4/22/2007	
710	68	4/22/2007	
710	74	4/22/2007	
710	300-301	4/22/2007	J

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
(EAST) US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB Inventor search utilising eDan and EAST	4/22/2007	CHUN-KUAN Lee